# International Rectifier

# POWER MOSFET THRU-HOLE (TO-254AA)

**Product Summary** 

Part Number	RDS(on)	ΙD
IRFM450	0.415 Ω	12A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

# IRFM450 JANTX2N7228 JANTXV2N7228 REF: MIL-PRF-19500/592 500V, N-CHANNEL

**HEXFET® MOSFET TECHNOLOGY** 



#### Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

### **Absolute Maximum Ratings**

	Parameter		Units
ID @ VGS = 10V, TC = 25°C   Continuous Drain Current		12	
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	8.0	Α
I <sub>DM</sub>	Pulsed Drain Current ①	48	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	750	mJ
IAR	Avalanche Current ①	12	Α
EAR	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③	3.5	V/ns
TJ	Operating Junction	-55 to 150	
TSTG Storage Temperature Range			°C
	Lead Temperature	300 ( 0.063 in.(1.6mm) from case for 10s)	
	Weight	9.3 (Typical)	g

For footnotes refer to the last page

# Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions		
BVDSS	Drain-to-Source Breakdown Voltage	500	_	_	V	VGS = 0V, ID = 1.0mA		
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.68	_	V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA		
RDS(on)	Static Drain-to-Source On-State	_	_	0.415	Ω	VGS = 10V, ID = 8.0A (4)		
	Resistance	_	_	0.515	32	VGS = 10V, ID = 12A		
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA		
9fs	Forward Transconductance	6.5	_	_	S (7)	V <sub>DS</sub> > 15V, I <sub>DS</sub> = 8.0A ④		
IDSS	Zero Gate Voltage Drain Current	_	_	25	μΑ	V <sub>DS</sub> = 400V ,V <sub>GS</sub> =0V		
		_	_	250	μΑ	V <sub>DS</sub> = 400V,		
						$V_{GS} = 0V, T_{J} = 125$ °C		
IGSS	Gate-to-Source Leakage Forward	_	_	100	- ^	VGS = 20V		
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	VGS = -20V		
Qg	Total Gate Charge	_	_	120		VGS =10V, ID = 12A		
Qgs	Gate-to-Source Charge	_	_	19	nC	$V_{DS} = 250V$		
Q <sub>gd</sub>	Gate-to-Drain ('Miller') Charge	_	_	70				
td(on)	Turn-On Delay Time	_	_	35		$V_{DD} = 250V, I_D = 12A,$		
tr	Rise Time	_	l —	190		$V_{GS} = 10V$ , $R_{G} = 2.35\Omega$		
td(off)	Turn-Off Delay Time	_	_	170	ns			
tf	Fall Time	_	_	130				
LS+LD	Total Inductance		6.8	_	nΗ	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)		
C <sub>iss</sub>	Input Capacitance	_	2700	_		VGS = 0V, VDS = 25V		
Coss	Output Capacitance	_	600	_	pF	f = 1.0MHz		
Crss	Reverse Transfer Capacitance	_	240	_				

# **Source-Drain Diode Ratings and Characteristics**

	Parameter		Min	Тур	Max	Units	Test Conditions	
Is	Continuous Source Current (	Body Diode)	_	_	12			
ISM	Pulse Source Current (Body	Diode) ①	_	_	48	Α		
VSD	Diode Forward Voltage		_	_	1.7	V	$T_j = 25$ °C, $I_S = 12A$ , $V_{GS} = 0V$ ④	
trr	Reverse Recovery Time		_	_	1600	nS	Tj = 25°C, IF = 12A, di/dt ≤ 100A/μs	
QRR	Reverse Recovery Charge		_	_	14	μC	V <sub>DD</sub> ≤ 50V ④	
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L <sub>S</sub> + L <sub>D</sub> .						

## **Thermal Resistance**

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	-	_	0.83		
RthJCS	Case-to-Sink		0.21	_	°C/W	
R <sub>th</sub> JA	Junction-to-Ambient		_	48		Typical socket mount

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

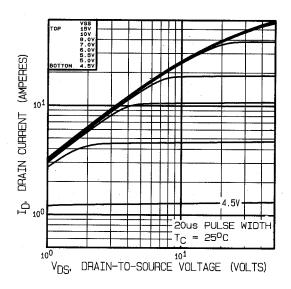


Fig 1. Typical Output Characteristics

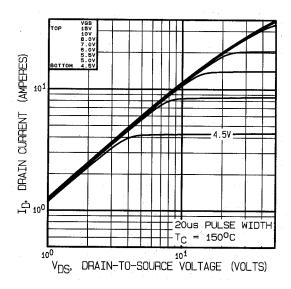


Fig 2. Typical Output Characteristics

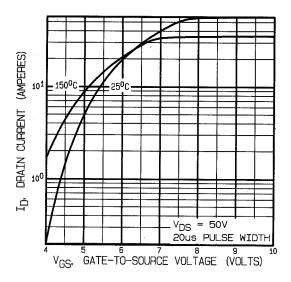
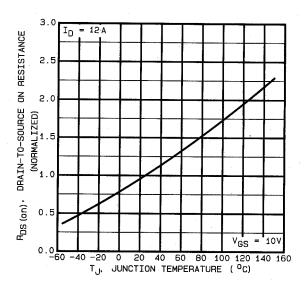
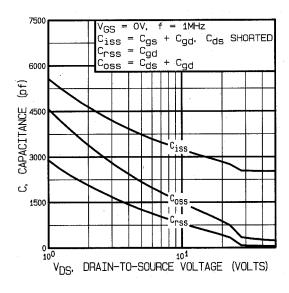


Fig 3. Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature

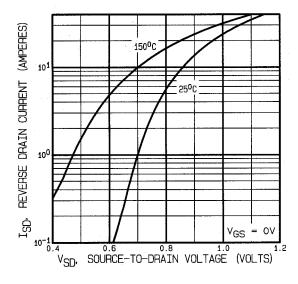


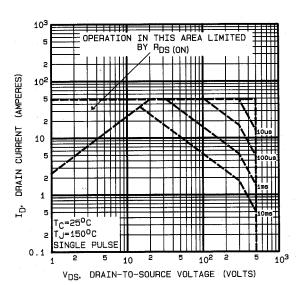
V<sub>DS</sub> = 400V V<sub>DS</sub> = 250V V<sub>DS</sub> = 100V V<sub>DS</sub> = 100V FOR TEST CIRCUIT SEE FIGURE 13 Q<sub>g</sub>. TOTAL GATE CHARGE (nC)

I<sub>D</sub> = 12A

**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

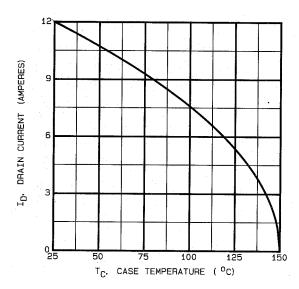
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage





**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

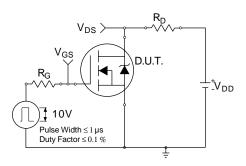


Fig 10a. Switching Time Test Circuit

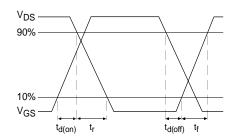


Fig 10b. Switching Time Waveforms

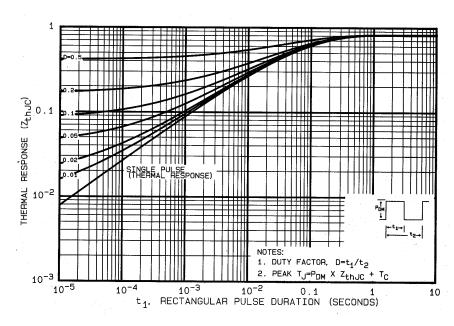


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

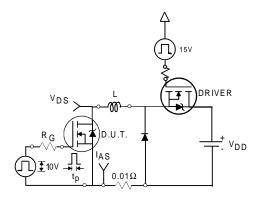


Fig 12a. Unclamped Inductive Test Circuit

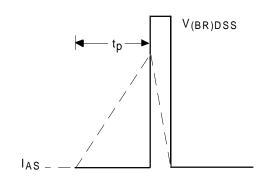


Fig 12b. Unclamped Inductive Waveforms

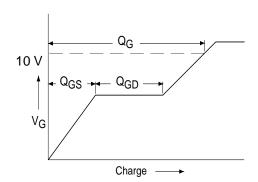
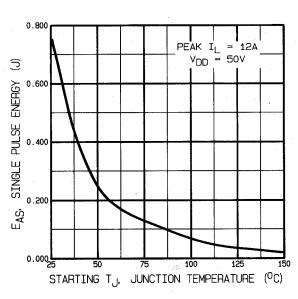


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

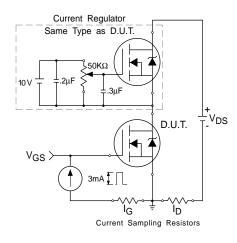


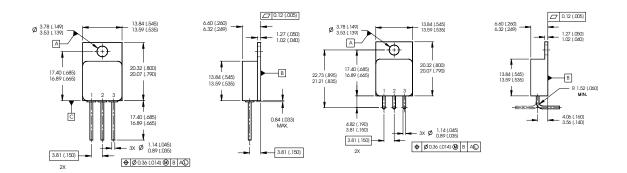
Fig 13b. Gate Charge Test Circuit



#### Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② VDD = 50V, starting TJ = 25°C, L= 10.4mH Peak I<sub>L</sub> =12A, V<sub>G</sub>S = 10V
- ③ ISD ≤ 12A, di/dt ≤ 130A/ $\mu$ s, VDD ≤ 500V, TJ ≤ 150°C
- 4 Pulse width  $\leq 300 \ \mu s$ ; Duty Cycle  $\leq 2\%$

#### Case Outline and Dimensions — TO-254AA



- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES). 3. CONTROLLING DIMENSION: INCH.
- 4. CONFORMS TO JEDEC OUTLINE TO-254AA.

#### PIN ASSIGNMENTS

- 1 = DRAN
- 2 = SOURCE 3 = GATE

#### **CAUTION BERYLLIA WARNING PER MIL-PRF-19500**

Packages containing beryllia shall not be ground, sandblasted, machined or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.



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